



## **FOM Technologies and Xenocs enter strategic partnership to accelerate materials innovation.**

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**FOM Technologies, proudly announce our collaboration with Xenocs, a global leader in advanced X-ray characterization technologies. This strategic partnership brings together two innovation-driven organizations at the forefront of material science research.**

Xenocs SAS, headquartered in Grenoble, France, provides cutting-edge solutions for nanoscale characterization, empowering researchers and engineers to push the boundaries of material development. With over 25 years of experience, Xenocs is internationally recognized for its pioneering work in small- and wide-angle X-ray scattering (SAXS/WAXS) and X-ray imaging techniques, complemented by advanced software tools and an exceptional customer support structure. Their technologies are used by leading academic and industrial laboratories worldwide.

*“We are excited about the collaboration with FOM Technologies and look forward to jointly providing our customers with a platform for the development and in situ characterization of materials for energy storage, renewable energy, and much more.”* - Peter Høghøj, CEO at Xenocs SAS.

Through this partnership, FOM Technologies' FOM photonR2R, precision slot-die coater, will integrate with Xenocs' state-of-the-art X-ray instrumentation to enable seamless in situ characterization of thin films—an essential step in optimizing processes for batteries, solar cells, membranes, printed electronics, and more. Together, we aim to bridge the gap between deposition and analysis, empowering researchers to gain faster insights into film morphology, uniformity, and internal structure during the coating process.

Michael Stadi, Group CEO of FOM Technologies states: *“This collaboration is rooted in a shared mission to accelerate scientific discovery. Combining our scalable coating solutions with Xenocs' world-class analytical instruments creates new opportunities for researchers to characterize and refine their materials in real time, ultimately speeding up the innovation cycle.”*

As both companies continue to expand globally, with Xenocs and FOM Technologies each operating in Europe, North America, and Asia, this collaboration strengthens our ability to support scientists across geographies and disciplines, by providing additional specialized solutions. For FOM Technologies, the collaboration helps add a new application area with potential commercialization.

### **About Xenocs**

Xenocs provides solutions for nanoscale characterization, empowering researchers and engineers in the development and production of advanced materials. With 25 years of expertise, Xenocs is recognized for its innovation in X-ray technology, the outstanding performance of its instruments and softwares, and its commitment to exceptional customer service.

Learn more at [www.xenocs.com](http://www.xenocs.com)

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**Attachments**

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